Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination | | |
|-------------------------|---|--|--|
| 10772518 | DYE ET AL. | | |
| Examiner | Art Unit | | |
| Chen, Qing | 2191 | | |

| | SEARCHED | | | | | |
|------|----------|--|--|--|--|--|
| Date | Examine | | | | | |
| | Date | | | | | |

| SEARCH NOTES | | | | | |
|---|-----------|----------|--|--|--|
| Search Notes | Date | Examiner | | | |
| EAST Search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; | 3/8/2007 | QC | | | |
| IBM_TDB) See Search History Printout | | | | | |
| 717/104-113; 715/733,740 (limited class search) | 3/8/2007 | QC | | | |
| EAST Inventor Name Search and Assignee Search (US-PGPUB; USPAT) | 3/8/2007 | QC | | | |
| See Search History Printout | | | | | |
| NPL Search (ACM) See Printout | 3/12/2007 | QC | | | |
| PLUS Search | 3/8/2007 | QC | | | |
| PALM Inventor Name Search | 3/8/2007 | QC | | | |

| INTERFERENCE SEARCH | | | | | |
|---------------------|----------|------|---------|--|--|
| Class | Subclass | Date | Examine | | |

Part of Paper No.: 20070308